

**Notice of References Cited**

Application/Control No.

10/561,581

Applicant(s)/Patent Under  
Reexamination  
GAUDON ET AL.

Examiner

NATHAN H. EMPIE

Art Unit

1792

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,244,691	09-1993	Valente et al.	427/126.2
*	B	US-2003/0003237	01-2003	Seabaugh et al.	427/421
*	C	US-2003/0152704	08-2003	Haruta et al.	427/372.2
*	D	US-2004/0115416	06-2004	Nonninger et al.	428/304.4
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Mukherjee, A et al. "Correlation Between Slurry Rheology, Green Density, and Sintered Density of Tape Cast Yttria Stabilised Zirconia" Ceramics International 27 (2001) pg 731-739.
	V	Bitterlich, B et al. "Rheological Characterization of Water-based Slurries for the Tape Casting Process" Ceramics International 28 (2002) pg 675-683.
	W	Lee, J. et al. "Dip Coating of Alumina Films by the Sol-gel Method" J. Mater. Res., Vol. 8, No. 12, Dec 1993 pg 3151 - 3157.
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.